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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/712,648	BELCHER ET AL.	
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Belix M. Ortiz

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted with Alford Kindred	1/25/2007	вмо		
Consulted with Sammuel Rimell	1/25/2007	вмо		